



Designation: D6988 – 08

Standard Guide for Determination of Thickness of Plastic Film Test Specimens¹

This standard is issued under the fixed designation D6988; the number immediately following the designation indicates the year of original adoption or, in the case of revision, the year of last revision. A number in parentheses indicates the year of last reappraisal. A superscript epsilon (ϵ) indicates an editorial change since the last revision or reappraisal.

1. Scope*

1.1 This guide covers the determination of the thickness of plastic films where the thickness is used directly in determining the results of tests for various properties. Use this practice except as otherwise required in material specifications or in applicable test standards.

NOTE 1—Films are defined as having thicknesses ≤ 0.250 mm [≤ 0.010 in.].

NOTE 2—Alternative methods are acceptable if they meet the requirements of measurement precision as noted in this guide.

NOTE 3—This guide is not intended to address the sampling techniques or the measurement of film thickness for the commercial classification of commercial products or for quality control purposes.

1.2 The values stated in SI units are to be regarded as the standard.

1.3 *This standard does not purport to address all of the safety concerns, if any, associated with its use. It is the responsibility of the user of this standard to establish appropriate safety and health practices and determine the applicability of regulatory requirements prior to use.*

NOTE 4—This standard and ISO 4593 address the same subject matter but differ in technical content.

2. Referenced Documents

2.1 *ASTM Standards:*²

D618 Practice for Conditioning Plastics for Testing

D883 Terminology Relating to Plastics

D4805 Terminology for Plastics Standards (Withdrawn 2002)³

D5947 Test Methods for Physical Dimensions of Solid Plastics Specimens

D6287 Practice for Cutting Film and Sheeting Test Specimens

¹ This guide is under the jurisdiction of ASTM Committee D20 on Plastics and is the direct responsibility of Subcommittee D20.19 on Film, Sheeting, and Molded Products.

Current edition approved Nov. 1, 2008. Published November 2008. Originally approved in 2003. Last previous edition approved in 2007 as D6988 - 07. DOI: 10.1520/D6988-08.

² For referenced ASTM standards, visit the ASTM website, www.astm.org, or contact ASTM Customer Service at service@astm.org. For *Annual Book of ASTM Standards* volume information, refer to the standard's Document Summary page on the ASTM website.

³ The last approved version of this historical standard is referenced on www.astm.org.

2.2 *ISO Standard:*

ISO 472 Plastics—Vocabulary⁴

3. Terminology

3.1 *Definitions*—See Terminologies D883 and D4805, and ISO 472 for definitions pertinent to this guide.

3.2 *Definitions of Terms Specific to This Standard:*

3.2.1 *absolute uncertainty (of a measurement)*, n —the smallest division that can be read directly on the instrument used for measurement.

3.2.2 *calibration*, n —the set of operations that establishes, under specified conditions, the relationship between values measured or indicated by an instrument or system, and the corresponding reference standard or known values derived from the appropriate reference standards.

3.2.3 *dead-weight micrometer*, n —an instrument capable of measuring the thickness of thin films utilizing a weight to apply uniform pressure to the specimen.

3.2.4 *verification*, n —proof, with the use of calibrated standards or standard reference materials that the calibrated instrument is operating within specified requirements.

4. Summary of Methods

4.1 This guide describes four different methods for the thickness measurement of plastic film specimens. The methods (identified as Methods A, B, C, and D) use different micrometers that actuate the weights in different manners or utilize different means of reading the thickness.

4.2 It is permissible to use other instruments, including non-contact instruments and instruments using alternative readout systems in place of dials provided they meet or exceed the precision requirements noted in this practice.

5. Significance and Use

5.1 This guide is intended to provide recommendations and suggested good practices to determine precise dimensions when necessary for the calculation of properties expressed in physical units. It is not intended to replace practical thickness

⁴ Available from American National Standards Institute (ANSI), 25 W. 43rd St., 4th Floor, New York, NY 10036.

*A Summary of Changes section appears at the end of this standard

measurements based on commercial portable tools, nor is it implied that thickness measurements made by the procedures will agree exactly.

6. Apparatus

6.1 The instruments described in this guide share many common features:

6.1.1 A dead-weight gauge calibrated in accordance with the guidelines described in **Appendix X2** and consisting of the following:

NOTE 5—Additional guidance for calibration and verification of gauges can be found in Test Method **D5947**.

NOTE 6—Since there is such a wide variety of instruments in use, there can be significant differences in the accuracy of different instrument types. The values stated for each type of apparatus are intended to be typical of that type of instrument.

6.1.1.1 A presser foot that moves in an axis perpendicular to the anvil face;

6.1.1.2 The surfaces of the presser foot and anvil (which contact the specimen) parallel to within $2.5\ \mu\text{m}$;

6.1.1.3 A spindle, vertically oriented if a dead-weight apparatus;

6.1.1.4 An indicator essentially capable of repeatable readings within $\pm 0.001\ \text{mm}$ at zero setting or within $\pm 0.001\ \text{mm}$ when using a steel gauge block;

6.1.1.5 A frame, housing the indicator, of such rigidity that a load of 15 N applied to the housing, out of contact with the presser foot spindle (or any weight attached thereto), will produce a deflection of the frame not greater than the smallest scale division or digital count on the indicator;

6.1.1.6 If employed, a dial diameter of at least 50 mm and graduated continuously to read directly to the nearest $2.5\ \mu\text{m}$. The dial can be equipped with a revolution counter that displays the number of complete revolutions of the large hand, or

6.1.1.7 An electronic instrument having a digital readout in place of the dial indicator if that instrument meets all of the other requirements of this guide, and

6.1.1.8 The force applied to the presser foot spindle and the force necessary to register a change in the indicator reading shall be less than the force that will cause deformation of the specimen. The force applied to the presser foot spindle and the force necessary to just prevent a change in the indicator reading shall be more than the minimum permissible force specified for a specimen.

6.2 Apparatus A—Manually Operated Thickness Gauge:

6.2.1 An instrument having a presser foot and spindle that is manually lifted and lowered.

6.3 Apparatus B—Automatically Operated Thickness Gauge:

6.3.1 A pneumatic or motor-operated instrument having a presser foot spindle that is lifted and lowered either by a pneumatic cylinder or by a constant-speed motor through a mechanical linkage such that the rate of descent (for a specified range of distances between the presser foot surface and anvil) and dwell time on the specimen are within the limits specified for the material being measured.

6.3.2 A preferred drop rate between 0.750 and 1.500 mm/s between 0.625 and 0.025 mm on the dial and a capacity of at least 0.775 mm.

6.4 Apparatus C—Manually Operated Thickness Gauge with Linear Optical Encoder:

6.4.1 Similar to Apparatus A except it employs a digital device with an electronic readout capable of repeatable readings to within $\pm 1\ \mu\text{m}$ at zero setting or on a steel gauge block and a linear optical encoder using a scale of increments not less than 100 lines/mm and capable of reading within $0.5\ \mu\text{m}$ with a 10 mm range.

6.5 Apparatus D—Automatically Operated Thickness Gauge with Digital Display:

6.5.1 Similar to Apparatus B except it employs an electronic device with a digital readout capable of a resolution not less than $0.5\ \mu\text{m}$ and repeatable readings to within $\pm 1\ \mu\text{m}$ at zero setting or on a steel gauge block.

6.5.2 A preferred drop rate between 0.750 and 1.500 mm/s between 0.625 and 0.025 mm on the dial and a capacity of at least 0.775 mm.

6.6 Other Instruments:

6.6.1 Other instruments are commercially available that utilize different methods of measuring thickness. These are generally non-contact devices employing ultrasonic response, electrical capacitance, or similar material properties that can be correlated to thickness. Some of these devices are also designed to provide a means of measuring discreet sections of film in a continuous scanning mode. Instruments of this nature are acceptable provided they meet or exceed the precision requirements noted in this practice and the requirements of the applicable material or product specifications or applicable test standards.

7. Test Specimens

7.1 The test specimens shall be prepared from plastic films that have been cut to the required dimensions according to Practice **D6287**.

7.2 Allow specimens to equilibrate at $23 \pm 2^\circ\text{C}$ ($73.4 \pm 3.6^\circ\text{F}$) and $50 \pm 10\%$ relative humidity in accordance with Procedure A of Practice **D618** unless otherwise specified by agreement or the relevant ASTM material specification.

7.3 Unless otherwise specified, make all dimension measurements at the same conditions used for equilibration.

7.4 For each specimen, take precautions to prevent damage or contamination that will adversely affect the measurements.

8. Procedure

8.1 General Guidelines:

NOTE 7—In this section, the word “method” denotes a combination of both a specific apparatus and a procedure describing its use.

8.1.1 The selection of a method for measurement of film thickness is influenced by the characteristics of the film for measurement. Each material and, in some cases, film construction in the case of multi-layer structures, will differ in its response to test method parameters, which include, but are not limited to, compressibility, rate of loading, ultimate load, dwell

time, and dimensions of the presser foot and anvil. For a specific plastic material or structure, these responses can, in some cases, cause measurements made using one method to differ significantly from measurements made using another method. The effects due to differences in elasticity are addressed in [Appendix X1](#).

TABLE 1 Instrument Guidelines

Method	Diameter of Presser Foot or Spindle, mm ^A	Pressure on Specimen, Approximate, kPa ^B
A	3.2 to 12.7	160 to 185
B	3.2 to 12.7	160 to 185
C	3.2 to 12.7	160 to 185
D	3.2 to 12.7	160 to 185

^A It is known that the diameters of the pressure foot and spindle can influence the results. Data obtained from instruments with different geometries may not be comparable.

^B The total force applied to the specimen shall be less than the force that will cause permanent deformation or distortion of the specimen. For very thin or deformable films, a practical pressure range of 5 to 70 kPa has been found to be suitable.

NOTE 8—The pressure exerted by the gauge on the specimen being measured shall not distort or deform the specimen. For thin films, ≤ 0.025 mm [0.001 in.], or films which exhibit visual deformation during measurement, a maximum pressure of 70 kPa [10 psi] is suggested. For thicker or stiffer films, a pressure range between 160 and 185 kPa [23 and 27 psi] is suggested. See [Table 1](#).

NOTE 9—An electronic gauge can be substituted for the dial gauge in Method A or B if the presser foot and anvil meet the requirements of that method.

8.1.2 The presence of contaminating substances on the surfaces of the test specimens, presser foot, anvil, or spindle can interfere with dimension measurements and result in erroneous readings. To help prevent this interference, select only clean specimens for testing, and keep them and the dimension measuring instrument covered until ready to make measurements. (**Warning**—Cleaning the presser foot and anvil surfaces as described in [X2.1](#) can cause damage to digital electronic gauges resulting in very expensive repairs by the instrument manufacturer. Obtain procedures for cleaning such electronic gauges from the instrument manufacturer to prevent these costs.)

8.1.3 One thickness determination per specimen or the average thickness determined by a continuous scanning instrument is acceptable if it can be demonstrated that the overall thickness does not deviate $> \pm 10\%$ from the average. This is especially applicable if measurements are being made for reference, that is, to report nominal film thickness, and are not required for the determination of specific properties.

8.1.4 Some instruments do not require calibration. For these instruments, periodic verification procedures should be conducted according to the recommendations of the instrument supplier.

8.2 Method A:

8.2.1 Using Apparatus A and specimens in conformance with [Section 7](#), place the instrument on a solid, level, clean table or bench that is free of excessive vibration. Confirm that the anvil and presser foot surfaces are clean. Adjust the zero point.

8.2.2 Lower the presser foot on an area of the specimen for measurement. Observe this reading.

8.2.3 Raise the presser foot slightly.

8.2.4 Move the specimen to the first measurement location, and lower the presser foot to a reading approximately 0.007 to 0.010 mm higher than the initial reading of [8.2.2](#).

8.2.5 Drop the foot onto the specimen (see **Warning** in [8.1.2](#)).

NOTE 10—This procedure minimizes small errors present when the pressure foot is lowered slowly onto the specimen and does not allow the presser foot to seat properly.

8.2.6 Observe the reading. After correcting the observed indicated dimension, record the corrected dimension value. A method for developing a calibration correction curve is described in [X2.4](#).

8.2.7 Move the specimen to another measurement position, and repeat the steps given in [8.2.3](#) through [8.2.6](#).

8.2.8 Unless otherwise specified, make and record at least three dimension measurements on each specimen. The arithmetic mean of all dimension values is the dimension of the specimen.

8.2.9 Recheck the instrument zero setting after measuring each specimen. If a change is observed, this is usually indicative of contamination on the contact surfaces and will require cleaning. (See **Warning** in [8.1.2](#) and [Note 9](#).)

8.3 Method B:

8.3.1 Using Apparatus B and specimens in conformance with [Section 7](#), place the instrument on a solid, level, clean table or bench that is free of excessive vibration. Confirm that the anvil and presser foot surfaces are clean.

8.3.2 Apply power to the motor or air to the pneumatics, and allow the instrument to reach a thermal equilibrium with the ambient. Equilibrium is attained when the zero point adjustment becomes negligible. Do not stop the motor or remove the air until all of the measurements are made. This will minimize any tendency to disturb the thermal equilibrium between the instrument and ambient during the dimension measurements.

8.3.3 Insert and position a specimen for the first measurement when the opening between the presser foot and anvil is near its maximum.

8.3.4 Observe the dial reading while the presser foot is at rest on the specimen surface. After correcting the observed indicated dimension, record the corrected dimension value. A method for developing a calibration correction curve is described in [X2.4](#).

8.3.5 While the presser foot is near its maximum lift, move the specimen to another measurement position, and repeat the steps given in [8.3.3](#) and [8.3.4](#).

8.3.6 Unless otherwise specified, make and record at least three thickness measurements on each specimen. The arithmetic mean of all dimension values is the thickness of the specimen.

8.3.7 Recheck the instrument zero setting after measuring each specimen. If a change is observed, this is usually indicative of contamination on the contact surfaces and will require cleaning. (See **Warning** in [8.1.2](#) and [Note 9](#).)

8.4 Method C:

8.4.1 Using Apparatus C and specimens in conformance with [Section 7](#), place the instrument on a solid, level, clean